

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/964,918	GRANT ET AL.	
	Examiner	Art Unit	Page 1 of 1
Binh X Tran	1765		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,446,641	09-2002	Nakatani, Yasuo	134/1.3
	B	US-6,352,867	03-2002	Couteau et al.	438/8
	C	US-6,316,169	11-2001	Vahedi et al.	430/329
	D	US-6,013,570	01-2000	Yu et al.	438/595
	E	US-5,942,449	08-1999	Meikle, Scott G.	438/747
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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